











CDCM1802

SCAS759B - APRIL 2004-REVISED NOVEMBER 2015

# CDCM1802 Clock Buffer With Programmable Divider, LVPECL I/O + Additional LVCMOS Output

#### **Features**

- Distributes One Differential Clock Input to One LVPECL Differential Clock Output and One LVCMOS Single-Ended Output
- Programmable Output Divider for Both LVPECL and LVCMOS Outputs
- 1.6-ns Output Skew Between LVCMOS and LVPECL Transitions Minimizing Noise
- 3.3-V Power Supply (2.5-V Functional)
- Signaling Rate Up to 800-MHz LVPECL and 200-MHz LVCMOS
- Differential Input Stage for Wide Common-Mode Range Also Provides VBB Bias Voltage Output for Single-Ended Input Signals
- Receiver Input Threshold ±75 mV
- 16-Pin VQFN Package (3.00 mm × 3.00 mm)

# Applications

- Networking and Data Communications
- Medical Imaging
- Portable Test and Measurement
- High-end A/V

## 3 Description

The CDCM1802 clock driver distributes one pair of differential clock input to one LVPECL differential clock output pair, Y0 and  $\overline{Y0}$ , and one single-ended LVCMOS output, Y1. It is specifically designed for driving 50- $\Omega$  transmission lines. The LVCMOS output is delayed by 1.6 ns over the PECL output stage to minimize noise impact during signal transitions.

The CDCM1802 has two control pins, S0 and S1, to select different output mode settings. The S[1:0] pins are 3-level inputs. Additionally, an enable pin EN is enable all outputs provided to disable or simultaneously. The CDCM1802 is characterized for operation from -40°C to 85°C.

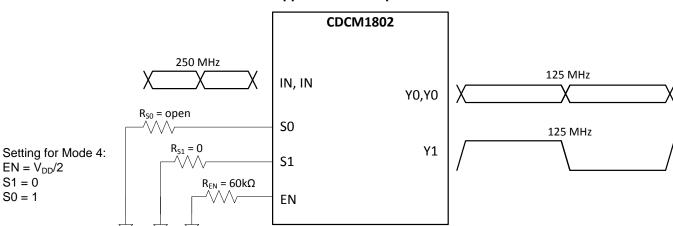
For single-ended driver applications, the CDCM1802 provides a VBB output pin that can be directly connected to the unused input as a common-mode voltage reference.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
CDCM1802	VQFN (16)	3.00 mm × 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### Application Example





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# 4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

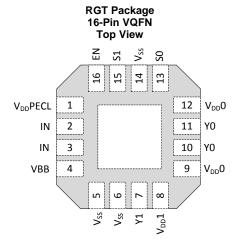
## Changes from Revision A (July 2008) to Revision B

**Page** 

Added ESD Ratings table, Thermal Information table, Feature Description section, Device Functional Modes,
 Application and Implementation section, Power Supply Recommendations section, Layout section, Device and
 Documentation Support section, and Mechanical, Packaging, and Orderable Information section.



# 5 Pin Configuration and Functions



**Pin Functions** 

PIN			DECODINE IOU			
NAME	NO.	I/O	DESCRIPTION			
EN	16	l (with 60-kΩ pullup)	ENABLE. Enables or disables all outputs simultaneously; The EN pin offers three different configurations: tie to GND (logic 0), external $60\text{-k}\Omega$ pulldown resistor (pull to $V_{DD}/2$ ) or left floating (logic 1); EN = 1: outputs on according to S0 and S1 setting EN = $V_{DD}/2$ : outputs on according to S0 and S1 setting EN = 0; outputs Y[1:0] off (high-impedance); see Table 1 for details.			
IN	2		Differential input clock. Input stage is sensitive and has a wide common mode range.			
IN	3	I Differential input	Therefore, almost any type of differential signal can drive this input (LVPECL, LVDS, CML, HSTL). Since the input is high-impedance, it is recommended to terminate the PCB transmission line before the input (for example, with 100- $\Omega$ across input). The input can also be driven by a single-ended signal, if the complementary input is tied to a dc reference voltage (for example, $V_{\rm CC}/2$ ). The inputs deploy an ESD structure protecting the inputs in case of an input voltage exceeding the rails by more than $\approx$ 0.7 V. Reverse biasing of the IC through this inputs is possible and must be prevented by limiting the input voltage < VDD.			
S0	13	1	Colort mode of apparties. Defines the system to refine action of VO and VA. Fook his office.			
S1	15	l (with 60-kΩ pullup)	Select mode of operation. Defines the output configuration of Y0 and Y1. Each pin offers three different configurations: tied to GND (logic 0), external 60-k $\Omega$ pulldown resistor (pull to $V_{DD}/2$ ) or left floating (logic 1); see Table 1 for details.			
Y1	7	0	LVCMOS clock output. This output provides a copy of IN or a divided down copy of clock IN based on the selected mode of operation: S0, S1, and EN. Also, this output can be disabled by tying $V_{DD}1$ to GND.			
Y0	10	0	LVPECL clock output. This output provides a copy of IN or a divided down copy of clock IN			
Y0	11	LVPECL	based on the selected mode of operation: S1, S0, and EN. If Y0 output is unused, the output can simply be left open to save power and minimize noise impact to Y1.			
VBB	4	0	Output bias voltage used to bias unused complementary input $\overline{\text{IN}}$ for single-ended input signals. The output voltage of VBB is V <sub>DD</sub> -1.3 V. When driving a load, the output current drive is limited to about 1.5 mA.			
V <sub>DD</sub> PECL <sup>(1)</sup>	1	Supply	Supply voltage PECL input + internal logic			
V <sub>DD</sub> 0 <sup>(1)</sup>	9, 12	Supply	PECL output supply voltage for output Y0; Y0 can be disabled by pulling $V_{DD}$ 0 to GND. <b>Caution:</b> In this mode no voltage from outside may be forced because internal diodes could be forced in a forward direction. Thus, it is recommended to leave the output disconnected.			
V <sub>DD</sub> 1	8	Supply	Supply voltage CMOS output; The CMOS output can be disabled by pulling $V_{DD}1$ to GND. Caution: In this mode no voltage from outside may be forced, because internal diodes could be forced in forward direction. Thus, it is recommended to leave Y1 unconnected, tied to GND, or terminated into GND.			
$V_{SS}$	5, 6, 14	Supply	Device ground			

(1)  $\ \ V_{DD}0,\,V_{DD}1,$  and  $V_{DD}PECL$  should have the same value.



## 6 Specifications

#### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

		MIN	MAX	UNIT
$V_{DD}$	Supply voltage	-0.3	3.8	V
VI	Input voltage	-0.2	$(V_{DD} + 0.2)$	V
Vo	Output voltage	-0.2	$(V_{DD} + 0.2)$	V
Yn, $\overline{\text{Yn}}$ , $I_{\text{OSD}}$	Differential short circuit current	Cont		
TJ	Maximum junction temperature	125	125	°C
T <sub>stg</sub>	Storage temperature	-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 6.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±3000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1500	V

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

## 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
$V_{DD}$	Supply voltage	3	3.3	3.6	V
$V_{DD}$	Supply voltage (only functionality)	2.375		3.6	V
T <sub>A</sub>	Operating free-air temperature	-40		85	°C

#### 6.4 Thermal Information

		CDCM1802	
	THERMAL METRIC <sup>(1)</sup>	RGT (VQFN)	UNIT
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	48.4	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	66.9	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	22.5	°C/W
ΨЈТ	Junction-to-top characterization parameter	1.7	°C/W
ΨЈВ	Junction-to-board characterization parameter	22.5	°C/W
R <sub>0</sub> JC(bot)	Junction-to-case (bottom) thermal resistance	5.8	°C/W

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

Product Folder Links: CDCM1802

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



#### 6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT
LVPEC	L INPUT IN, ĪN		,	11	
f <sub>clk</sub>	Input frequency		0	800	MHz
$V_{CM}$	High-level input common mode		1	V <sub>DD</sub> - 0.3	V
.,		See (1)	500	1300	
$V_{IN}$	Input voltage swing between IN and IN	See (2)	150	1300	mV
I <sub>IN</sub>	Input current	V <sub>I</sub> = V <sub>DD</sub> or 0 V		±10	μA
R <sub>IN</sub>	Input impedance		300		kΩ
Cı	Input capacitance at IN, IN			1	pF
LVPEC	L OUTPUT DRIVER Y0, Y0		<u>,                                      </u>	<u>,                                      </u>	
f <sub>clk</sub>	Output frequency (see Figure 3)		0	800	MHz
V <sub>OH</sub>	High-level output voltage	Termination with 50 Ω to V <sub>DD</sub> - 2 V	V <sub>DD</sub> - 1.18	V <sub>DD</sub> – 0.81	V
V <sub>OL</sub>	Low-level output voltage	Termination with 50 Ω to V <sub>DD</sub> - 2 V	V <sub>DD</sub> - 1.98	V <sub>DD</sub> – 1.55	V
Vo	Output voltage swing between Y and $\overline{Y}$ (see Figure 3)	Termination with 50 Ω to V <sub>DD</sub> - 2 V	500		mV
l <sub>OZL</sub>	Outrat 0 state	V <sub>DD</sub> = 3.6 V, V <sub>O</sub> = 0 V		5	μΑ
l <sub>ozh</sub>	Output 3-state	$V_{DD} = 3.6 \text{ V}, V_{O} = V_{DD} - 0.8 \text{ V}$		10	μΑ
Co	Output capacitance	$V_O = V_{DD}$ or GND		1	рF
LOAD	Expected output load			50	Ω
LVCMC	OS OUTPUT PARAMETER, Y1				
f <sub>clk</sub>	Output frequency <sup>(3)</sup> (see Figure 4)		0	200	MHz
		V <sub>DD</sub> = min to max, I <sub>OH</sub> = −100 μA	V <sub>DD</sub> - 0.1		
$V_{OH}$	High-level output voltage	$V_{DD} = 3 \text{ V}, I_{OH} = -6 \text{ mA}$	2.4		V
		$V_{DD} = 3 \text{ V}, I_{OH} = -12 \text{ mA}$	2		
		$V_{DD}$ = min to max, $I_{OL}$ = 100 $\mu$ A		0.1	
$V_{OL}$	Low-level output voltage	V <sub>DD</sub> = 3 V, I <sub>OL</sub> = 6 mA		0.5	V
		V <sub>DD</sub> = 3 V, I <sub>OL</sub> = 12 mA		0.8	
I <sub>OH</sub>	High-level output current	V <sub>DD</sub> = 3.3 V, V <sub>O</sub> = 1.65 V		-29	mA
I <sub>OL</sub>	Low-level output current	V <sub>DD</sub> = 3.3 V, V <sub>O</sub> = 1.65 V		37	mA
l <sub>OZ</sub>	High-impedance state output current	V <sub>DD</sub> = 3.6 V, V <sub>O</sub> = V <sub>DD</sub> or 0 V		±5	μΑ
Co	Output capacitance	V <sub>DD</sub> = 3.3 V		2	pF
Load	Expected output loading (see Figure 9)			10	pF

<sup>(1)</sup> Required to maintain AC specifications

<sup>(2)</sup> Required to maintain device functionality

<sup>(3)</sup> Operating the CDCM1802 LVCMOS output above the maximum frequency will not cause a malfunction to the device, but the Y1 output signal swing will not achieve enough signal swing to meet the output specification. Therefore, the CDCM1802 can be operated at higher frequencies, while the LVCMOS output Y1 becomes unusable.



## 6.6 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
LVPECL OU	ITPUT DRIVER Y0, $\overline{\text{Y0}}$				<u> </u>	
t <sub>Duty</sub>	Output duty cycle distortion <sup>(1)</sup>	Crossing point-to-crossing point distortion	-50		50	ps
t <sub>sk(pp)</sub>	Part-to-part skew	Any Y0 (see Note A in Figure 7)		50		ps
t <sub>r</sub> /t <sub>f</sub>	Rise and fall time	20% to 80% of V <sub>OUTPP</sub> (see Figure 8)	200		350	ps
LVPECL INF	PUT-TO-LVPECL OUTPUT PARAMET	ER				
t <sub>pd(lh)</sub>	Propagation delay rising edge	VOX to VOX	320		600	ps
t <sub>pd(hl)</sub>	Propagation delay falling edge	VOX to VOX	320		600	ps
t <sub>sk(p)</sub>	LVPECL pulse skew (see Note B in Figure 7)	VOX to VOX			100	ps
LVCMOS O	JTPUT PARAMETER, Y1					
t <sub>skLVCMOS(o)</sub>	Output skew between the LVCMOS output Y1 and LVPECL output Y0	VOX to V <sub>DD</sub> / 2 (see Figure 7)		1.6		ns
t <sub>Duty</sub>	Output duty cycle distortion <sup>(2)</sup>	Measured at V <sub>DD</sub> / 2	-150		150	ps
t <sub>sk(pp)</sub>	Part-to-part skew	Y1 (see Note A in Figure 7)		300		ps
t <sub>pd(lh)</sub>	Propagation delay rising edge from IN to Y1	VOX to V <sub>DD</sub> / 2 load (see Figure 9)	1.6		2.6	ns
t <sub>pd(hl)</sub>	Propagation delay falling edge from IN to Y1	VOX to V <sub>DD</sub> / 2 load (see Figure 9)	1.6		2.6	ns
t <sub>r</sub>	Output rise slew rate	20% to 80% of swing (see Figure 9)	1.4	2.3		V/ns
t <sub>f</sub>	Output fall slew rate	80% to 20% of swing (see Figure 9)	1.4	2.3		V/ns

 <sup>(1)</sup> For a 800-MHz signal, the 50-ps error would result into a duty cycle distortion of ±4% when driven by an ideal clock input signal.
 (2) For a 200-MHz signal, the 150-ps error would result in a duty cycle distortion of ±3% when driven by an ideal clock input signal.

#### 6.7 Jitter Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<sup>†</sup> jitterLVPECL	Additive phase jitter from input to LVPECL output Y0 (see Figure 1)	12 kHz to 20 MHz, f <sub>out</sub> = 250 MHz to 800 MHz, divide by 1 mode			0.15	ps rms
		50 kHz to 40 MHz, f <sub>out</sub> = 250 MHz to 800 MHz, divide by 1 mode			0.25	ps rms
	Additive phase jitter from input to LVCMOS output Y1 (see Figure 2)	12 kHz to 20 MHz, f <sub>out</sub> = 250 MHz, divide by 1 mode			0.25	ps rms
<sup>t</sup> jitterLVCMOS		50 kHz to 40 MHz, f <sub>out</sub> = 250 MHz, divide by 1 mode			0.4	ps rms

## 6.8 Supply Current Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		R	TEST CONDITIONS	MIN	TYP	MAX	UNIT
I <sub>DD</sub>	Supply current	Full load	All outputs enabled and terminated with 50 $\Omega$ to $V_{DD}$ – 2 $V$ on LVPECL outputs and 10 pF on LVCMOS output, f = 800 MHz for LVPECL outputs and 200 MHz for LVCMOS, $V_{DD}$ = 3.3 $V$		100		mA
		No load	Outputs enabled, no output load, f = 800 MHz for LVPECL outputs and 200 MHz for LVCMOS, $V_{DD}$ = 3.6 V			85	mA
I <sub>DDZ</sub> Supply current, 3-state		-state	All outputs 3-state by control logic, f = 0 Hz, V <sub>DD</sub> = 3.6 V			0.5	mA

Product Folder Links: CDCM1802



# 6.9 Control Input Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Rpullup	Internal pullup resistor on S0, S1, and EN input		42	60	78	kΩ
$V_{IH(H)}$	Three level input high, S0, S1, and EN pin (1)		$0.9 \times V_{DD}$			٧
$V_{IM(M)}$	Three level input MID, S0, S1, and EN pin		$0.3 \times V_{DD}$		$0.7 \times V_{DD}$	٧
$V_{IL(L)}$	Three level low, S0, S1, and EN pin				$0.1 \times V_{DD}$	٧
I <sub>IH</sub>	Input current, S0, S1, and EN pin	$V_I = V_{DD}$			-5	μA
I <sub>IL</sub>	Input current, S0, S1, and EN pin	$V_I = GND$	38		85	μΑ

<sup>(1)</sup> Leaving this pin floating automatically pulse the logic level high to  $V_{DD}$  through an internal pullup resistor of 60 k $\Omega$ .

# 6.10 Timing Requirements

		MIN	NOM	MAX	UNIT
t <sub>su</sub>	Setup time, S0, S1, and EN pin before clock IN	25			ns
t <sub>h</sub>	Hold time, S0, S1, and EN pin after clock IN	0			ns
t <sub>(disable)</sub>	Time between latching the EN low transition and when all outputs are disabled (how much time is required until the outputs turn off)		10		ns
t <sub>(enable)</sub>	Time between latching the EN low-to-high transition and when outputs are enabled based on control settings (how much time passes before the outputs carry valid signals)		1		μs

# 6.11 Bias Voltage VBB

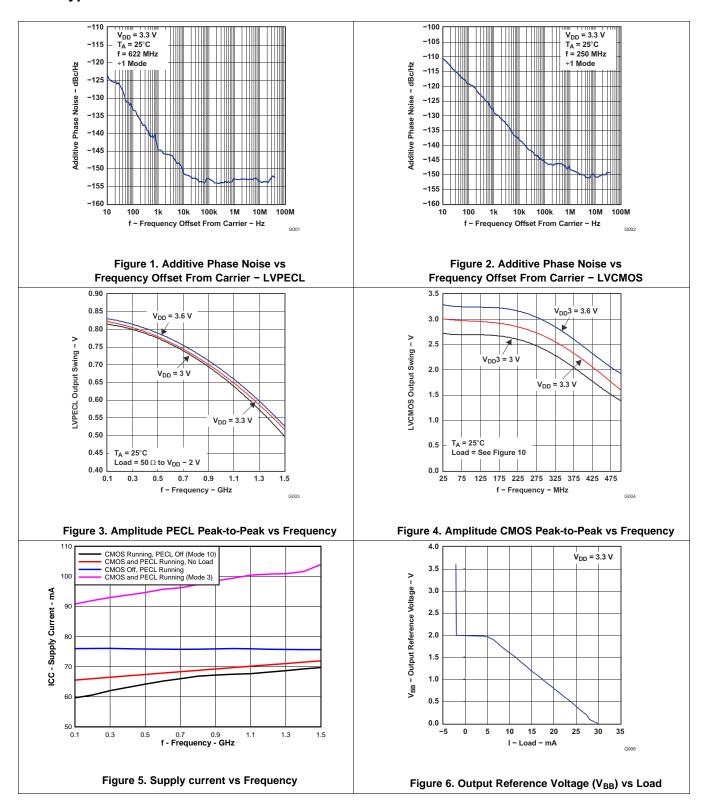
over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT
VBB	Output reference voltage	$V_{DD} = 3 V - 3.6 V$ , $I_{BB} = -0.2 \text{ mA}$	V <sub>DD</sub> – 1.4	V <sub>DD</sub> – 1.2	V

Product Folder Links: CDCM1802

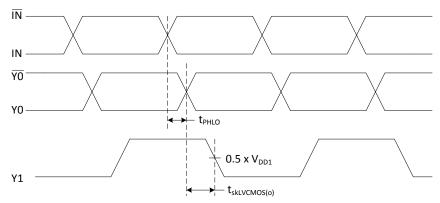
# TEXAS INSTRUMENTS

## 6.12 Typical Characteristics





## 7 Parameter Measurement Information



- A. Part-to-part skew,  $t_{sk(pp)}$ , is calculated as the greater of:
  - The difference between the fastest and the slowest  $t_{pd(LH)n}$  across multiple devices
  - The difference between the fastest and the slowest  $t_{pd(HL)n}$  across multiple devices
- B. Pulse skew,  $t_{sk(p)}$ , is calculated as the magnitude of the absolute time difference between the high-to-low ( $t_{pd(HL)}$ ) and the low-to-high ( $t_{pd(LH)}$ ) propagation delays when a single switching input causes Y0 to switch,  $t_{sk(p)} = |t_{pd(HL)} t_{pd(LH)}|$ . Pulse skew is sometimes referred to as *pulse width distortion or duty cycle skew*.

Figure 7. Waveforms for Calculation of  $t_{sk(p)}$  and  $t_{sk(pp)}$ 

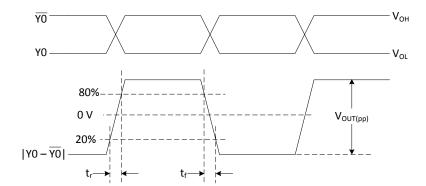


Figure 8. LVPECL Differential Output Voltage and Rise and Fall Time

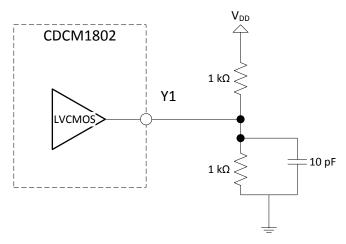


Figure 9. LVCMOS Output Loading During Device Test

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# **Parameter Measurement Information (continued)**

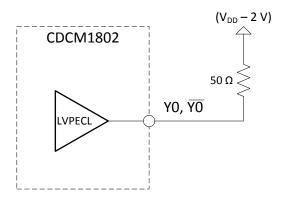


Figure 10. LVPECL Output Loading During Device Test

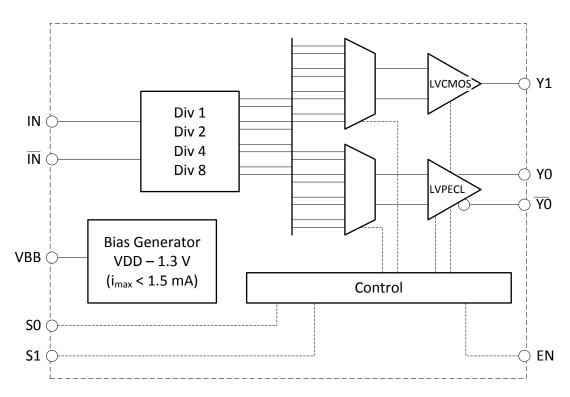


#### 8 Detailed Description

#### 8.1 Overview

The CDCM1802 is a clock buffer with a programmable divider. There is one LVCMOS and one LVPECL output. The LVCMOS output is specifically designed for driving  $50-\Omega$  transmission lines. It is delayed by 1.6 ns over the PECL output stage to minimize noise impact during signal transitions. Both outputs can be divided individually by 1, 2, 4, and 8. Divider settings can be selected with three 3-level control pins.

#### 8.2 Functional Block Diagram



#### 8.3 Feature Description

The CDCM1802 has two control pins, S0 and S1, to select different output mode settings. The S[1:0] pins are 3-level inputs. Additionally, an enable pin EN is provided to disable or enable all outputs simultaneously. For single-ended driver applications, the CDCM1802 provides a VBB output pin that can be directly connected to the unused input as a common-mode voltage reference.

#### 8.4 Device Functional Modes

#### 8.4.1 Control Pin Settings

The CDCM1802 has three control pins, S0, S1, and the enable pin (EN) to select different output mode settings. All three inputs (S0, S1, EN) are 3-level inputs. In addition, the EN input allows disabling all outputs and place them into a Hi-Z (or tristate) output state when pulled to GND.



#### **Device Functional Modes (continued)**

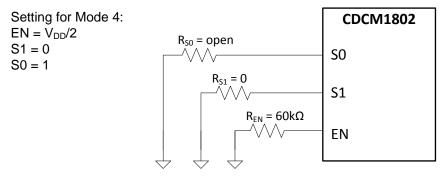


Figure 11. Control Pin Setting for Example

Each control input incorporates a  $60\text{-k}\Omega$  pullup resistor. Thus, it is easy to choose the input setting by designing a resistor pad between the control input and GND. To choose a logic zero, the resistor value must be zero. Setting the input high requires leaving the resistor pad empty (no resistor installed). For setting the input to  $V_{DD}/2$ , the installed resistor needs a value of  $60\text{ k}\Omega$  with a tolerance better or equal to 10%.

		0.4		LVPECL <sup>(1)</sup>	LVCMOS
MODE	EN	S1	S0	Y0	Y1
0	0	X	X	Off (high-z)	Off (high-z)
1	V <sub>DD</sub> /2	0	V <sub>DD</sub> /2	/1	/1
2	V <sub>DD</sub> /2	V <sub>DD</sub> /2	1	/1	/2
3	1	0	0	/1	/4
4	V <sub>DD</sub> /2	0	1	/2	/2
5	1	0	1	/2	/4
6	V <sub>DD</sub> /2	0	0	/4	/4
7	V <sub>DD</sub> /2	1	0	/4	/8
8	V <sub>DD</sub> /2	V <sub>DD</sub> /2	V <sub>DD</sub> /2	/8	/1
9	1	1	0	/8	/4
10	1	1	1	Off (high-z)	/4

Table 1. Selection Mode Table

#### 8.4.2 Device Behavior During RESET and Control Pin Switching

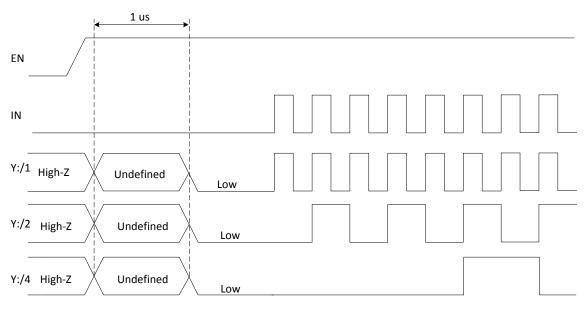
# 8.4.2.1 Output Behavior When Enabling the Device (EN = $0 \rightarrow 1$ )

In disable mode (EN = 0), all output drivers are switched in high-Z mode. The bandgap, current references, the amplifier, and the S0 and S1 control inputs are also switched off. In the same mode, all flip-flops will be reset. The typical current consumption is likely below  $500 \, \mu A$  (to be measured).

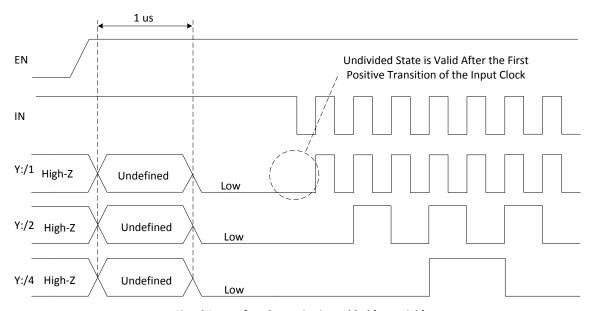
When the device will be enabled again it takes maximal 1  $\mu$ s for the settling of the reference voltage and currents. During this time the output Y0 and  $\overline{Y0}$  drive a high signal. Y1 is unknown (could be high or low). After the settle time, the outputs go into the low state. Due to the synchronization of each output driver signal with the input clock, the state of the waveforms after enabling the device look like those shown in Figure 12. The inverting input and output signal is not included. The Y:/1 waveform is the undivided output driver state.

<sup>(1)</sup> The LVPECL outputs are open emitter stages. Thus, if you leave the unused LVPECL output Y0 unconnected, then the current consumption is minimized and noise impact to remaining outputs is neglectable. Also, each output can be individually disabled by connecting the corresponding VDD input to GND.





Signal State After the Device is Enabled (IN = Low)



Signal State After the Device is Enabled (IN = High)

Figure 12. Waveforms

## 8.4.2.2 Enabling a Single Output Stage

If a single output stage becomes enabled:

- Y0 will either be low or high (undefined).
- Yo will be the inverted signal of Yo.

With the first positive clock transition, the undivided output becomes the input clock state. If a divide mode is used, the divided output states are equal to the actual internal divider. The internal divider does not get a reset while enabling single output drivers.

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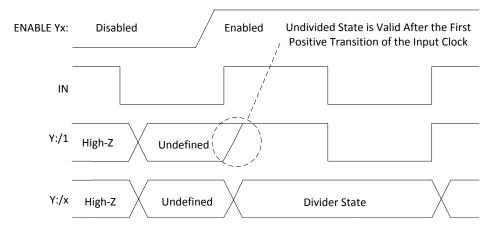


Figure 13. Signal State After an Output Driver Becomes Enabled While IN = 0

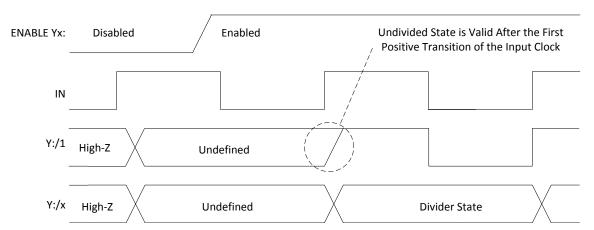


Figure 14. Signal State After an Output Driver Becomes Enabled While IN = 1



# 9 Application and Implementation

#### **NOTE**

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

# 9.1 Application Information

#### 9.1.1 LVPECL Receiver Input Termination

The input of the CDCM1802 has high impedance and comes with a very large common mode voltage range. For optimized noise performance it is recommended to properly terminate the PCB trace (transmission line).

Additional termination techniques can be found in the following application notes: SCAA062 and SCAA059.

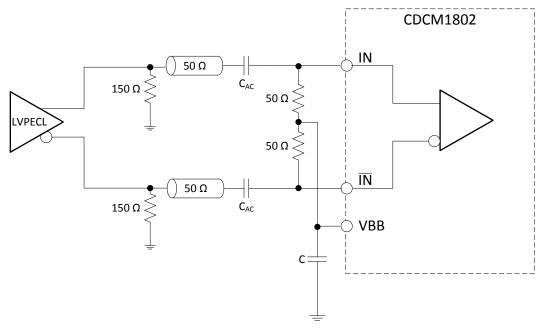


Figure 15. Recommended AC-Coupling LVPECL Receiver Input Termination

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## **Application Information (continued)**

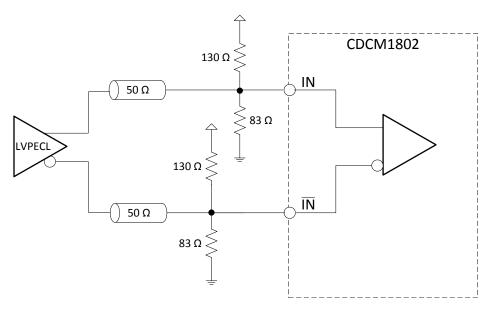
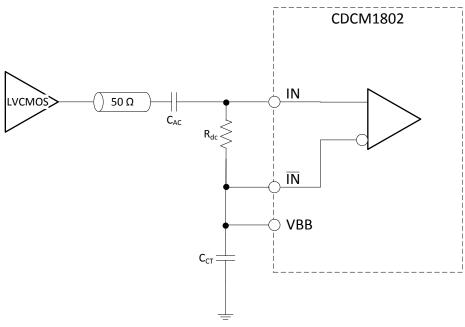


Figure 16. Recommended DC-Coupling LVPECL Receiver Input Termination

## 9.1.2 LVCMOS Receiver Input Termination



NOTE: C<sub>AC</sub> - AC-coupling capacitor (for example, 10 nF)

 $C_{CT}$  - Capacitor keeps voltage at  $\overline{\text{IN}}$  constant (for example, 10 nF)

 $R_{\text{dc}}$  – Load and correct duty cycle (for example, 50  $\Omega)$ 

V<sub>BB</sub> - Bias voltage output

Figure 17. Typical Application Setting for Single-Ended Input Signals Driving the CDCM1802



#### 9.2 Typical Application

Figure 18 shows a fanout buffer application.

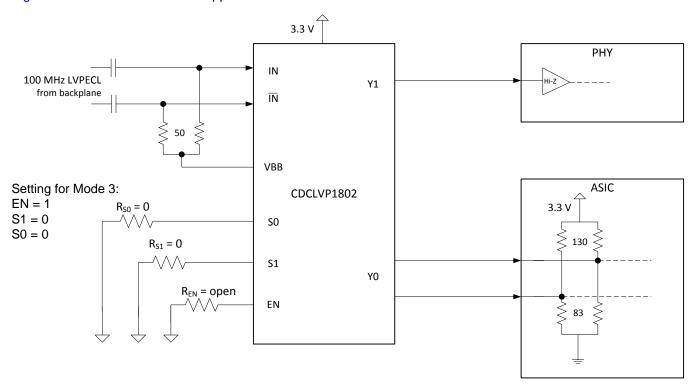


Figure 18. Typical Application Schematic, CDCM1802

#### 9.2.1 Design Requirements

The CDCM1802 shown in Figure 18 is configured to be able to select an 100-MHz LVPECL clock from the backplane. The signal can be fanned out to desired devices, as shown. The CDCM1802 offers internal dividers for both the LVCMOS and LVPECL output. In the example the LVCMOS output is divided by 4 and the LVPECL output is divided by 1.

- The PHY device receive a single ended 25-MHz signal. Optionally a series resistance can be placed close to the output to match transmission line impedance and reduce reflections.
- The ASIC is capable of DC coupling with a 3.3-V LVPECL driver such as the CDCM1802. This ASIC features
  internal termination so no additional components are needed.
- S0, S1, EN needs to be set accordingly to ensure the required divider setting.

#### 9.2.2 Detailed Design Procedure

Refer to LVPECL Receiver Input Termination for proper input terminations, dependent on single-ended or differential inputs.

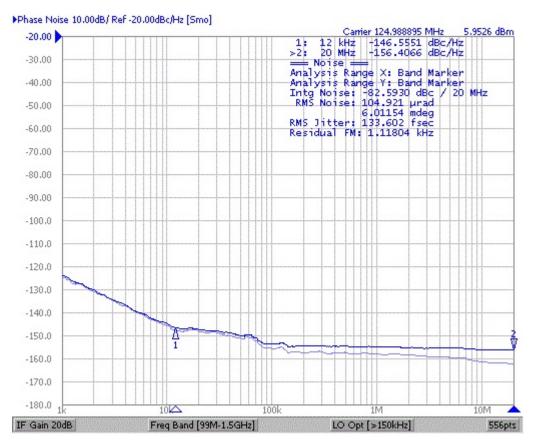
Refer to Figure 9 and Figure 10 for output termination schemes depending on the receiver application.

Refer to Table 1 for setting the desired divider modes.



# **Typical Application (continued)**

#### 9.2.3 Application Curve



Input (Vectron C5310A1) = 83 fs, rms

Output (LVPECL, divide 1) = 134 fs, rms

additive jitter = 105 fs, rms (typ)

Figure 19. Additive Jitter Performance



## 10 Power Supply Recommendations

High-performance clock buffers are sensitive to noise on the power supply, which can dramatically increase the additive jitter of the buffer. Thus, it is essential to reduce noise from the system power supply, especially when jitter or phase noise is very critical to applications.

Filter capacitors are used to eliminate the low-frequency noise from the power supply, where the bypass capacitors provide the very low impedance path for high-frequency noise and guard the power-supply system against the induced fluctuations. These bypass capacitors also provide instantaneous current surges as required by the device and must have low equivalent series resistance (ESR). To properly use the bypass capacitors, they must be placed very close to the power-supply terminals and laid out with short loops to minimize inductance. It is recommended to add as many high-frequency (for example, 0.1-µF) bypass capacitors as there are supply terminals in the package. It is recommended, but not required, to insert a ferrite bead between the board power supply and the chip power supply that isolates the high-frequency switching noises generated by the clock driver; these beads prevent the switching noise from leaking into the board supply. It is imperative to choose an appropriate ferrite bead with very low DC resistance to provide adequate isolation between the board supply and the chip supply, as well as to maintain a voltage at the supply terminals that is greater than the minimum voltage required for proper operation.

Figure 20 illustrates this recommended power-supply decoupling method.

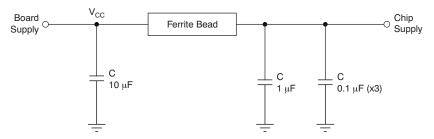


Figure 20. Power-Supply Decoupling

## 11 Layout

#### 11.1 Layout Guidelines

TI recommends taking special care of the PCB design for good thermal flow from the VQFN 16-pin package to the PCB. The current consumption of the CDCM1802 is fixed. JEDEC JESD51-7 specifies thermal conductivity for standard PCB boards.

Modeling the CDCM1802 with a 4-layer JEDEC board (including four thermal vias) results into 37.5°C max temperature with a  $R_{\rm BJA}$  of 40.84°C for 25°C ambient temperature.

To ensure sufficient thermal flow, it is recommended to design with four thermal vias in applications.

See the SCBA017 and the SLUA271 application notes for further package-related information.



# 11.2 Layout Example

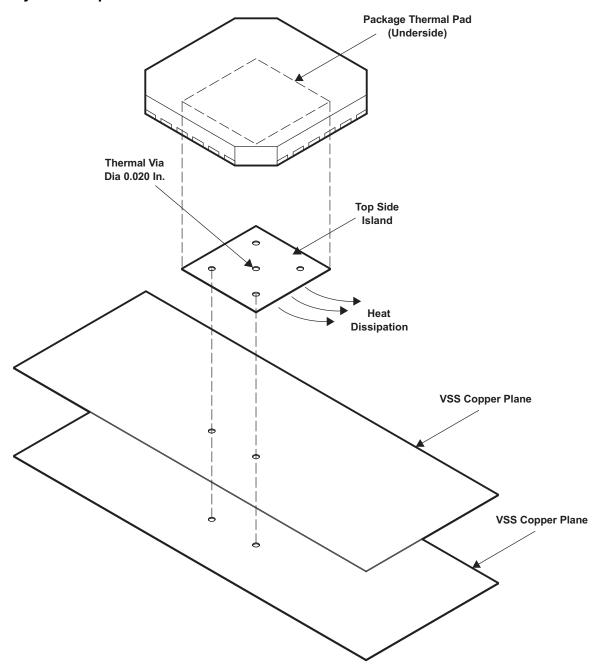


Figure 21. Recommended Thermal Via Placement



#### 11.3 Thermal Considerations

#### **Table 2. Package Thermal Resistance**

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$R_{\theta JA}$	VQFN-16 package thermal resistance with thermal vias in PCB <sup>(1)</sup>	4-layer JEDEC test board (JESD51-7) with four thermal vias of 22-mil diameter each, airflow = 0 ft/min		48.4		°C/W

 It is recommended to provide four thermal vias to connect the thermal pad of the package effectively with the PCB and ensure a good heat sink.

#### **Example:**

Calculation of the junction-lead temperature with a 4-layer JEDEC test board using four thermal vias:

T<sub>Chassis</sub> = 85°C (temperature of the chassis)

 $P_{effective} = I_{max} \times V_{max} = 85 \text{ mA} \times 3.6 \text{ V} = 306 \text{ mW}$  (max power consumption inside the package)

 $\Delta T_{Junction} = R_{\theta JA} \times P_{effective} = 40.8^{\circ}C/W \times 306 \text{ mW} = 12.48^{\circ}C$ 

 $T_{Junction} = \Delta T_{Junction} + T_{Chassis} = 12.48^{\circ}C + 85^{\circ}C = 97.48^{\circ}C \text{ (the maximum junction temperature of } T_{die-max} = 125^{\circ}C \text{ is not violated)}$ 

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## 12 Device and Documentation Support

#### 12.1 Device Support

#### 12.1.1 Third-Party Products Disclaimer

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#### 12.2 Documentation Support

#### 12.2.1 Related Documentation

SCAA062: DC-Coupling Between Differential LVPECL, LVDS, HSTL, and CML SCAA059: AC-Coupling Between Differential LVPECL, LVDC, HSTL, and CML

SCBA017: Quad Flatpack No-Lead Logic Packages

SLUA271: QFN/SON PCB Attachment

## 12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 12.4 Trademarks

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#### 12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 12.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Product Folder Links: CDCM1802





15-Apr-2015

#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CDCM1802RGTR	ACTIVE	QFN	RGT	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AJW	Samples
CDCM1802RGTRG4	ACTIVE	QFN	RGT	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AJW	Samples
CDCM1802RGTT	ACTIVE	QFN	RGT	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AJW	Samples
CDCM1802RGTTG4	ACTIVE	QFN	RGT	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	AJW	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



# PACKAGE OPTION ADDENDUM

15-Apr-2015

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# PACKAGE MATERIALS INFORMATION

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# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCM1802RGTR	QFN	RGT	16	3000	330.0	12.4	3.3	3.3	1.6	8.0	12.0	Q2
CDCM1802RGTT	QFN	RGT	16	250	330.0	12.4	3.3	3.3	1.6	8.0	12.0	Q2

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCM1802RGTR	QFN	RGT	16	3000	340.5	338.1	20.6
CDCM1802RGTT	QFN	RGT	16	250	340.5	338.1	20.6

# RGT (S-PVQFN-N16) PLASTIC QUAD FLATPACK NO-LEAD 3,15 2,85 - A В 3,15 2,85 PIN 1 INDEX AREA TOP AND BOTTOM 0,20 REF. SEATING PLANE 0,08 0,05 0,00 Ċ 16 THERMAL PAD SIZE AND SHAPE SHOWN ON SEPARATE SHEET

NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

12

- B. This drawing is subject to change without notice.
- C. Quad Flatpack, No-leads (QFN) package configuration.

13

- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.

16X  $\frac{0,30}{0,18}$ 

0,50

0,10 M C A B 0,05 M C

4203495/H 10/11

F. Falls within JEDEC MO-220.



# RGT (S-PVQFN-N16)

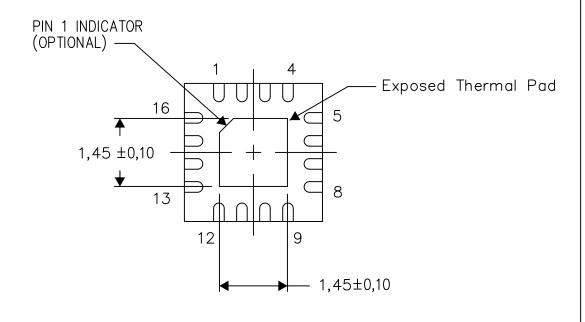
## PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

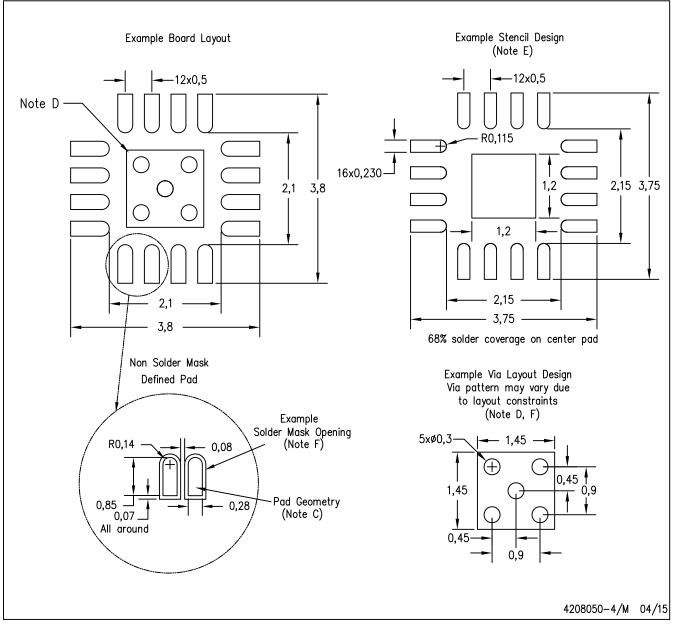
4206349-2/Z 08/15

NOTE: All linear dimensions are in millimeters



# RGT (S-PVQFN-N16)

# PLASTIC QUAD FLATPACK NO-LEAD



#### NOTES: A. All

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



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